

Li+ Charger Protection IC

Features

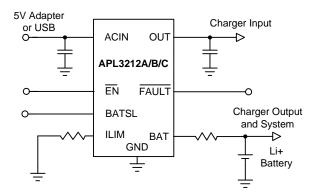
- Provide Input Over-Voltage Protection
- Programmable Input Over-Current Protection
- Battery Over-Voltage 4.35V/4.435V Protection
- Over-Temperature Protection
- High Immunity of False Triggering
- High Accuracy Protection Thresholds
- Fault Status Indication
- Enable Input
- Available in TDFN2x2-8 Package
- Lead Free and Green Devices Available
 (RoHS Compliant)

General Description

The APL3212A/B/C provide complete Li+ charger protections against over-voltage, over-current, and battery overvoltage. The IC is designed to monitor input voltage, input current, and battery voltage. When any of the monitored parameters are over the threshold, the IC removes the power from the charging system by turning off an internal switch. All protections also have deglitch time against false triggering due to voltage spikes or current transients. The APL3212A/B/C also provide over-temperature protection, a FAULT output pin to indicate the fault conditions, and the EN pin to allow the system to disable the IC.

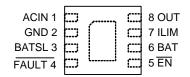
Applications

Simplified Application Circuit



- Smart Phones and PDAs
- Digital Still Cameras
- Portable Devices

Pin Configuration



TDFN2x2-8 (Top View)

= Exposed Pad (connected to ground plane for better heat dissipation)

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.



Ordering and Marking Information

APL3212A/B/C		 Assembly Material Handling Code Temperature Range Package Code QB : TDFN2x2-8 Operating Ambient Temperature Range I : -40 to 85 °C Handling Code TR : Tape & Reel Assembly Material G : Halogen and Lead Free Device 	
APL3212A QB:	L12A X •		X - Date Code
APL3212B QB:	L12B X		X - Date Code
APL3212C QB:	L12C X		X - Date Code

Note : ANPEC lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. ANPEC defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Rating	Unit
V _{ACIN}	IN Input Voltage (ACIN in to GND)	-0.3 to 30	V
V _{OUT} , V _{BAT}	OUT, BAT Pins to GND Voltage	-0.3 to 7	V
V _{LIM} , V _{FAULT} , V _{EN} , V _{BATSL}	ILIM, FAULT, EN, BATSL to GND Voltage	-0.3 to 7	V
TJ	Maximum Junction Temperature	150	°C
T _{STG}	Storage Temperature Range	-65 to 150	°C
T _{SDR}	Maximum Lead Soldering Temperature, 10 Seconds	260	°C

Note1: Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Thermal Characteristics

Symbol	Parameter	Typical Value	Unit
θ_{JA}	Junction to Ambient Thermal Resistance in Free Air (Note 2) TDFN2x2-8	75	°C/W

Note 2 : θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air.



Recommended Operating Conditions (Note3)

Symbol	Parameter	Range	Unit
V _{ACIN}	ACIN Input Voltage	4.5 to 5.5	V
I _{OUT}	OUT Output Current	0 to 2	A
TJ	Junction Temperature	-40 to 125	°C
T _A	Ambient Temperature	-40 to 85	°C

Note 2 : Refer th the typical application circuit.

Electrical Characteristics

Refer to the typical application circuit. These specifications apply over V_{IN} =5V, T_A = -40~85°C, unless otherwise specified. Typical values are at T_J =25°C.

Cumhal	Denemator	Teet Conditions	Α	PL3212A/E	3/C	Unit
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
ACIN INPL	JT CURRENT AND POWER-ON-R	ESET(POR)				
1	ACINI Supply Current	ĒN = Low	-	250	350	A
ACIN	CIN Supply Current	EN = High	-	100	150	μA
V _{ACIN}	ACIN POR Threshold	V _{IN} rising	2.4	2.6	2.8	V
	ACIN POR Hysteresis		200	250	300	
T _{B(ACIN)}	ACIN Power-On Blanking Time	V_{IN} rising to V_{OUT} rising	-	8	-	ms
INTERNAL	SWITCH ON RESISTANCE					
R _{on}	Power Switch On Resistance	I _{OUT} = 0.8A	-	130	-	mΩ
	OUT Discharge Resistance	V _{OUT} = 3V	-	500	-	Ω
INPUT OV	ER-VOLTAGE PROTECTION (OVE)				
		APL3212A, T _J =-40~125°C	5.7	5.85	6.0	
VOVP	Input OVP Threshold	APL3212B, T _J =-40~125°C	6.6	6.8	7.0	V
		APL3212C T _J =-40~125°C	7.0	7.2	7.4	
	Input OVP Hysteresis		-	250	-	mV
	Input OVP Propagation Delay	VACIN=5 to 12V, I _{UT} =10mA	-	1	-	μs
T _{ON(OVP)}	Input OVP Recovery Time		-	8	-	ms
OVER-CU	RRENT PROTECTION (OCP)					
	OCP Threshold	$R_{OCSET}=25k\Omega$, $T_{J}=25^{\circ}C$	900	1000	1100	mA
I _{OCP}	OCP Accuracy	I_{OCP} =800mA~2500mA(or 1A~1.5A), T_J=25°C	-10	-	+10	%
I _{OCP(MAX)}	Maximum OCP Threshold	$R_{OCSET}=0\Omega$, $T_{J}=25^{\circ}C$	-	3	-	А
$T_{B(OCP)}$	OCP Blanking Time		-	176	-	μs
T _{ON(OCP)}	OCP Recovery Time		-	64	-	ms



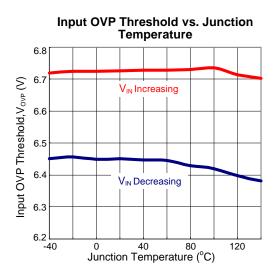
Electrical Characteristics

Refer to the typical application circuit. These specifications apply over V_{IN} =5V, T_A = -40~85°C, unless otherwise specified. Typical values are at T_A =25°C.

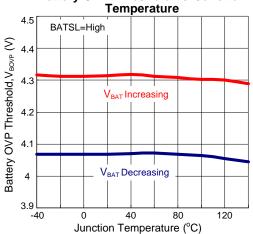
0	Parameter	To at Oan litiana	A	PL3212A/B	/C	Unit
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	
BATTERY	OVER-VOLTAGE PROTECTION	·				
VBOVP	Battery OVP Threshold	BATSL = Low or Floating, $T_J = -40 \sim 125^{\circ}C$	4.4	4.435	4.47	V
bow		$BATSL = High, T_J = -40 \sim 125^{\circ}C$	4.30	4.35	4.40	V
	Battery OVP Hysteresis		200	250	300	mV
I _{BAT}	BAT Pin Leakage Current	$V_{BAT} = 4.4V$	-	-	20	nA
$T_{B(BOVP)}$	Battery OVP Blanking Time		-	176	-	μs
BATSL LC	GIC LEVELS			•	,	
	BATSL Input Logic High		1.4	-	-	V
VBATSL	BATSL Input Logic Low		-	-	0.4	V
IBATSL	BATSL Input Current	V _{BATSL} = 3.3V	-	1.5	-	μA
N LOGIC	LEVELS	· ·				
	EN Input Logic High		1.4	-	-	V
$V_{\overline{EN}}$	EN Input Logic Low		-	-	0.4	V
	EN Internal Pull-Low Resistor		-	500	-	kΩ
AULT LO	GIC LEVELS AND DELAY TIME	•	•			
VFAULT	FAULT Output Low Voltage	Sink 5mA current	-	-	0.4	V
	FAULT Leakage Current	$V_{FAULT} = 5V$	-	-	1	μA
Thermal S	hutdown Protection	·	•			
Тотр	Thermal Shutdown Threshold		-	140	-	°C
	Thermal Shutdown Hysteresis		-	20	-	°C

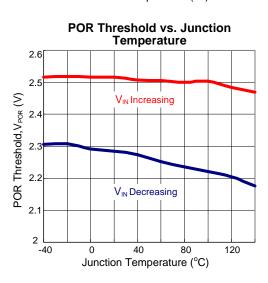


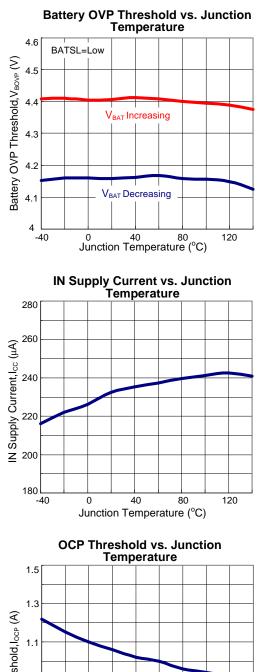
Typical Operating Characteristics

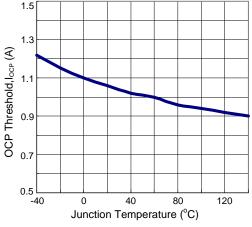


Battery OVP Threshold vs. Junction



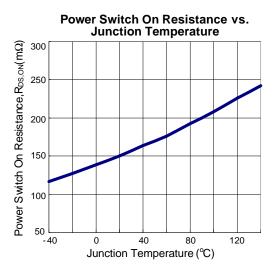


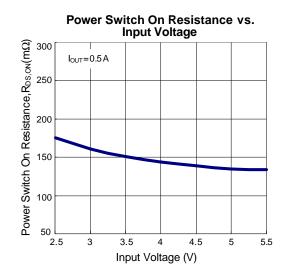






Typical Operating Characteristics

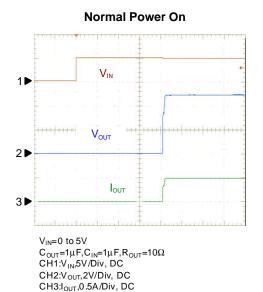






Operating Waveforms

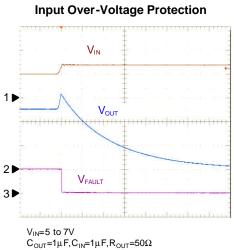
TIME:2ms/Div



1 ► V_{IN} 2 ► V_{OUT} 3 ► V_{FAULT}

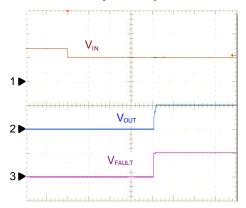
OVP at Power On

 $\begin{array}{l} \mathsf{V}_{\text{IN}}{=}0 \text{ to 7V} \\ \mathsf{C}_{\text{OUT}}{=}1\mu\mathsf{F},\mathsf{C}_{\text{IN}}{=}1\mu\mathsf{F},\mathsf{R}_{\text{OUT}}{=}10\Omega \\ \mathsf{CH1:V}_{\text{IN}}{,}5V/\text{Div}, \text{ DC} \\ \mathsf{CH2:V}_{\text{OUT}}{,}2V/\text{Div}, \text{ DC} \\ \mathsf{CH3:V}_{\text{FAULT}}{,}5V/\text{Div}, \text{ DC} \\ \mathsf{TIME:}2ms/\text{Div} \end{array}$



 $\begin{array}{l} \underset{Out}{\overset{(i)}{\underset{Out}{i}}=1\mu,F,C_{IN}=1\mu,F,R_{OUT}=50\\ CH1: V_{IN},5V/Div, DC\\ CH2: V_{OUT},2V/Div, DC\\ CH3: V_{FAULT},5V/Div, DC\\ TIME: 20\mu s/Div \end{array}$

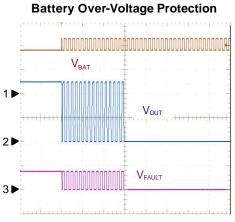
Recovery from Input OVP



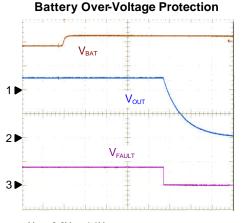
 $\begin{array}{l} \mathsf{V}_{\text{IN}} = 7 \mathsf{V} \text{ to } \mathsf{5} \mathsf{V} \\ \mathsf{C}_{\text{OUT}} = 1 \mu \mathsf{F}, \mathsf{C}_{\text{IN}} = 1 \mu \mathsf{F}, \mathsf{R}_{\text{OUT}} = 50 \Omega \\ \mathsf{C} \mathsf{H} 1 : \mathsf{V}_{\text{IN}}, \mathsf{5} \mathsf{V} / \mathsf{Div}, \mathsf{D} \mathsf{C} \\ \mathsf{C} \mathsf{H} 2 : \mathsf{V}_{\text{OUT}}, \mathsf{5} \mathsf{V} / \mathsf{Div}, \mathsf{D} \mathsf{C} \\ \mathsf{C} \mathsf{H} 3 : \mathsf{V}_{\text{FAULT}}, \mathsf{5} \mathsf{V} / \mathsf{Div}, \mathsf{D} \mathsf{C} \\ \mathsf{T} \mathsf{IME} : 2 \mathsf{ms} / \mathsf{Div} \end{array}$



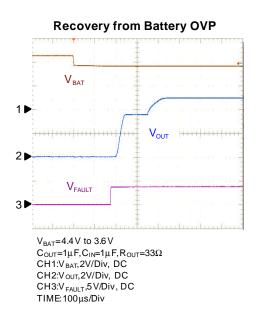
Operating Waveforms



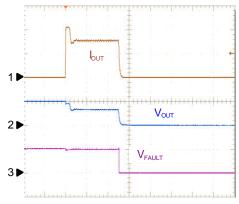
 $\begin{array}{l} \mathsf{V}_{\mathsf{BAT}}{=}3.6\mathsf{V} \text{ to } 4.4\mathsf{V} \text{ to } 3.6\mathsf{V} \\ \mathsf{C}_{\mathsf{OUT}}{=}1\mu\mathsf{F},\mathsf{C}_{\mathsf{IN}}{=}1\mu\mathsf{F},\mathsf{R}_{\mathsf{OUT}}{=}33\Omega \\ \mathsf{CH1:} \mathsf{V}_{\mathsf{BAT},2}\mathsf{V/Div},\mathsf{DC} \\ \mathsf{CH2:} \mathsf{V}_{\mathsf{OUT},2}\mathsf{V/Div},\mathsf{DC} \\ \mathsf{CH3:} \mathsf{V}_{\mathsf{FAUL},5}\mathsf{V/Div},\mathsf{DC} \\ \mathsf{TIME:}10\mathsf{ms/Div} \end{array}$



 $\begin{array}{l} \mathsf{V}_{\mathsf{BAT}}{=}3.6\mathsf{V} \text{ to } 4.4\mathsf{V} \\ \mathsf{C}_{\mathsf{OUT}}{=}1\mu\mathsf{F},\mathsf{C}_{\mathsf{IN}}{=}1\mu\mathsf{F},\mathsf{R}_{\mathsf{OUT}}{=}33\Omega \\ \mathsf{CH1:}\mathsf{V}_{\mathsf{BAT}}{,}2\mathsf{V}/\mathsf{Div},\mathsf{DC} \\ \mathsf{CH2:}\mathsf{V}_{\mathsf{OUT}}{,}2\mathsf{V}/\mathsf{Div},\mathsf{DC} \\ \mathsf{CH3:}\mathsf{V}_{\mathsf{FAULT}}{,}\mathsf{5V}/\mathsf{Div},\mathsf{DC} \\ \mathsf{TIME:}40\mu\mathsf{s}/\mathsf{Div} \end{array}$



Over-Current Protection



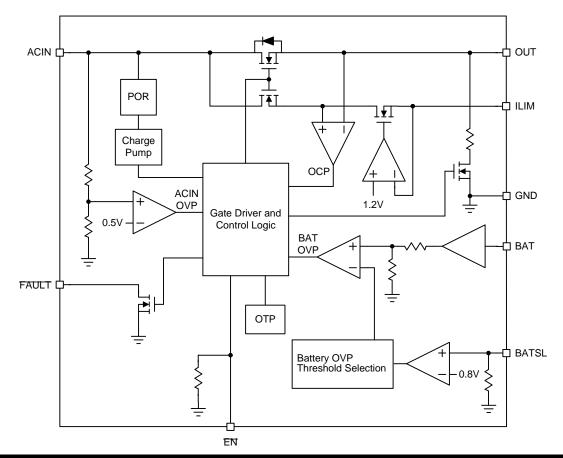
 $\begin{array}{l} C_{OUT} = 1 \mu F, C_{IN} = 1 \mu F \\ CH1 : I_{OUT}, 0.5 A / Div, DC \\ CH2 : V_{OUT}, 5 V / Div, DC \\ CH3 : V_{FAULT}, 5 V / Div, DC \\ TIME: 100 \mu s / Div \end{array}$



Pin Description

Р	IN	FUNCTION
NO.	NAME	FUNCTION
1	ACIN	Power Supply Input, connect to external DC supply. Connect external 1µF ceramic capacitor (minimum) to GND.
2	GND	Ground pin of the circuitry. All voltage levels are measured with respect to this pin.
3	BATSL	Battery OVP threshold selection: $V_{BATSL} = High, V_{BOVP} = 4.30V \sim 4.4V.$ $V_{BATSL} = Low, V_{BOVP} = 4.4V \sim 4.47V.$
4	FAULT	Fault Indication Pin. This pin goes low when input OVP, OCP or battery OVP is detected.
5	ĒN	Enable Input. Pull this pin to high to disable the device and pull this pin to low to enable device.
6	BAT	Battery OVP Sense Pin. Connect to positive terminal of battery through a resistor.
7	ILIM	Over-current Protection Setting Pin. Connect a resistor (R _{OCSET}) to GND to set the over-current threshold. When left open, the internal power FET will be turned off.
8	OUT	Output Pins. Output Voltage Pin. The output voltage follows the input voltage when no fault is detected
Exposed Pad	-	Exposed Thermal Pad. Connect this pad to system ground plane for good thermal conductivity.

Block Diagram





Typical Application Circuit

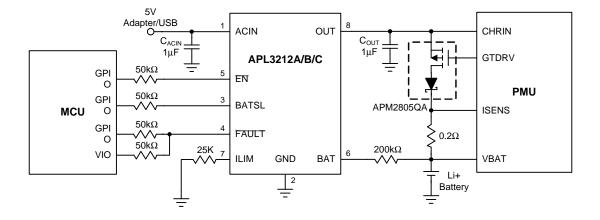


Figure 1. The Typical Protection Circuit for Charger Systems.

	Designation
C _{ACIN}	1μF, 25V, X5R, 0603 Murata GRM188R61E105K
C _{OUT}	1μF, 10V, X5R, 0603 Murata GRM188R61A105K

Murata website: www.murata.com



Function Description

ACIN Power-On-Reset (POR)

The APL3212A/B/C have a built-in power-on-reset circuit to keep the output shutting off until internal circuitry is operating properly. The POR circuit has hysteresis and a de-glitch feature so that it will typically ignore undershoot transients on the input. When input voltage exceeds the POR threshold and after 8ms blanking time, the output voltage starts a soft-start to reduce the inrush current.

Input Over-Voltage Protection (OVP)

The input voltage is monitored by the internal OVP circuit. When the input voltage rises above the input OVP threshold, the internal FET will be turned off within 1µs to protect connected system on OUT pin. When the input voltage returns below the input OVP threshold minus the hysteresis, the FET is turned on again after 8ms recovery time. The input OVP circuit has a 250mV hysteresis and a recovery time of $T_{ON(OVP)}$ to provide noise immunity against transient conditions.(see Figure 2.)

Over-Current Protection (OCP)

The output current is monitored by the internal OCP circuit. When the output current reaches the OCP threshold, the device limits the output current at OCP threshold level. If the OCP condition continues for a blanking time of $T_{B(OCP)}$, the internal power FET is turned off. After the recovery time of $T_{ON(OCP)}$, the FET will be turned on again and the output current is monitored again. The OCP threshold is programmed by a resistor R_{ILIM} connected from ILIM pin to GND. The OCP threshold is calculated by the following equation:

$$\mathsf{IOCP} = \frac{\mathsf{Kilim}}{\mathsf{Rilim}}$$

where K_{IIIM}=25000AΩ

Battery Over-Voltage Protection

The APL3212A/B/C monitor the BAT pin voltage for battery over-voltage protection. The battery OVP threshold is internally set to 4.35V. When the BAT pin voltage exceeds the battery OVP threshold for a blanking time of $T_{R(ROVP)}$,

the internal power FET is turned off. When the BP voltage returns below the battery OVP threshold minus the hysteresis, the FET is turned on again. The APL3212A/B/C have a built-in counter. When the total count of battery OVP fault reaches 16, the FET is turned off permanently, requiring either a $V_{\rm IN}$ POR or EN re-enable again to restart.

Over-Temperature Protection

When the junction temperature exceeds 140°C, the internal thermal sense circuit turns off the power FET and allows the device to cool down. When the device's junction temperature cools by 20°C, the internal thermal sense circuit will enable the device, resulting in a pulsed output during continuous thermal protection. Thermal protection is designed to protect the IC in the event of over temperature conditions. For normal operation, the junction temperature cannot exceed T₁=+125 °C.

FAULT Output

The APL3212A/B/C provide an open-drain output to indicate that a fault has occurred. When any of input OVP, OCP, battery OVP, is detected, the FAULT goes low to indicate that a fault has occurred. Since the FAULT pin is an open-drain output, connecting a resistor to a pull high voltage is necessary.

Enable/Shutdown

Pull the \overline{EN} pin voltage above 1.4V to disable the device and pull \overline{EN} pin voltage below 0.4V to enable the device. The \overline{EN} pin has an internal pull-down resistor and can be left floating. When the IC is latched off due to the total count of OCP or battery OVP reaches 16, disable and reenable the device with the \overline{EN} pin can clear the counter.

ESD Tests

The APL3212A/B/C VIN input pin fully supports the IEC61000-4-2. That means the VIN pin has immunity of \pm 15kV ESD discharge in Air condition, and immunity of \pm 8kV ESD discharge in Contact condition.

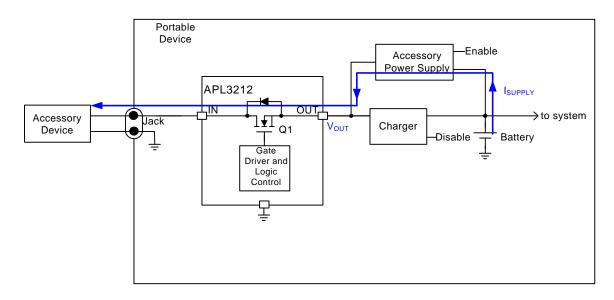


Function Description (Cont.)

Powering an Accessory Device

In some applications, such as USB On-The-Go, users need to power an accessory device by using the portable device's battery through the jack holes of AC adapter. The APL3212A/B/C provide reverse current flow path from OUT to IN.

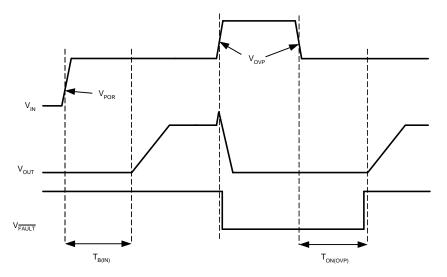
If $V_{OUT} > V_{POR} + 0.7V$, FET Q1 is turned on, and the reverse current does not flow through the diode but through Q1. Q1 will then remain ON as long as $V_{OUT} > V_{POR} - V_{POR} - V_{POR} + R_{DS_ON}$ *ISUPPLY. Within this voltage range, the reverse current capability is the same as the forward capability, 1.5A. It should be noted that there is no overcurrent protection in this direction.







Function Description (Cont.)





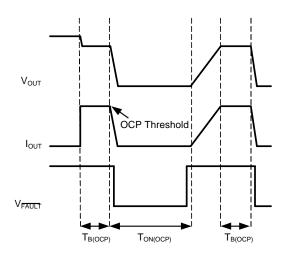


Figure 3. OCP Timing Chart



Function Description (Cont.)

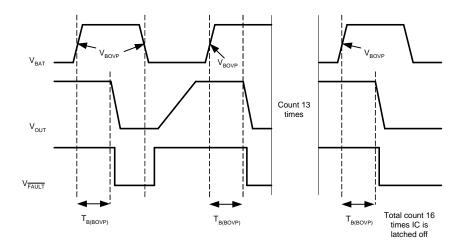


Figure 4. Battery OVP Timing Chart



Application Information

R_{BAT} Selection

Connect the BAT pin to the positive terminal of battery through a resistor R_{BAT} for battery OVP function. The R_{BAT} limits the current flowing from BAT to battery in case of BAT pin is shortened to VIN pin under a failure mode. The recommended value of R_{BAT} is $100k\Omega$. In the worse case of an IC failure, the current flowing from the BAT pin to the battery is:

(30V-3V)/ 100kΩ =270μA

where the 30V is the maximum IN voltage and the 3V is the minimum battery voltage. The current is so small and can be absorbed by the charger system.

The disadvantage with the large R_{BAT} is that the error of the battery OVP threshold will be increased. The additional error is the voltage drop across the R_{BAT} because of the BAT bias current. When R_{BAT} is 100k Ω , the worse-case additional error is 100k Ω x20nA=2mV, which is acceptable in most applications.

$\mathsf{R}_{_{\mathsf{EN}}}$ Selection

For the same reason as the BAT pin case, the EN pin should be connected to the MCU GPIO pin through a resistor. The value of the R_{EN} is dependent on the IO voltage of the MCU.

Since the IO voltage is divided by R_{EN} and \overline{EN} internal pull low resistor for \overline{EN} voltage. It has to be ensured that the \overline{EN} voltage is above the \overline{EN} logic high voltage when the GPIO output of the MCU is high.

FAULT Output

Since the FAULT pin is an open-drain output, connecting a resistor R_{UP} to a pull high voltage is necessary. It is also recommended that connect the FAULT to the MCU GPIO through a resistor R_{FAULT} . The R_{FAULT} prevents damage to the MCU under a failure mode. The recommended value of the resistors should be between 10k Ω to 100k Ω .

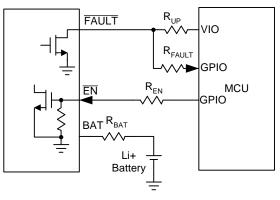


Figure 5. $\rm R_{\rm UP},\, \rm R_{\rm FAULT},\, \rm R_{\rm EN}$ and $\rm R_{\rm BAT}$

Capacitor Selection

The input capacitor is for decoupling and prevents the input voltage from overshooting to dangerous levels. In the AC adapter hot plug-in applications or load current step-down transient, the input voltage has a transient spike due to the parasitic inductance of the input cable. A 25V, X5R, dielectric ceramic capacitor with a value between 1μ F and 4.7μ F placed close to the IN pin is recommended.

The output capacitor is for output voltage decoupling, and also can be as the input capacitor of the charging circuit. At least, a 1μ F, 10V, X5R capacitor is recommended.

Layout Consideration

In some failure modes, a high voltage may be applied to the device. Make sure the clearance constraint of the PCB layout must satisfy the design rule for high voltage.

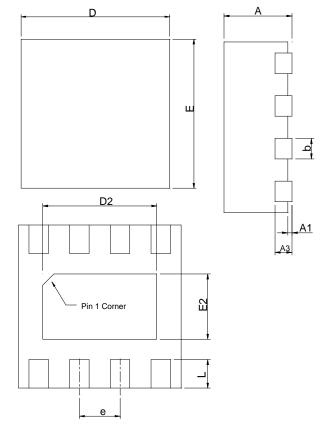
The exposed pad of the TDFN2x2-8 performs the function of channeling heat away. It is recommended that connect the exposed pad to a large copper ground plane on the backside of the circuit board through several thermal vias to improve heat dissipation.

The input and output capacitors should be placed close to the IC. R_{ILIM} also should be placed close to the IC. The high current traces like input trace and output trace must be wide and short.



Package Information

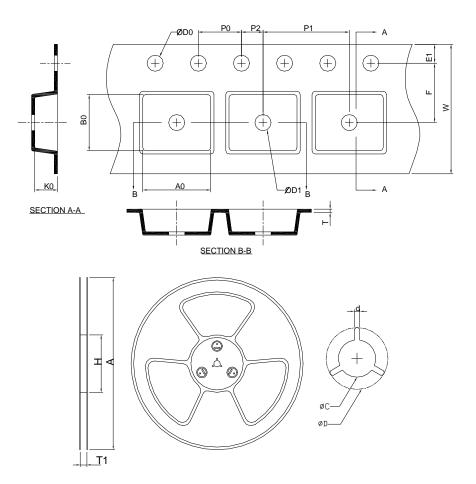
TDFN2x2-8



Ş		TDFN	l2x2-8			
SY MBO L	MILLIM	MILLIMETERS		MILLIMETERS		HES
6	MIN.	MAX.	MIN.	MAX.		
A	0.70	0.80	0.028	0.031		
A1	0.00	0.05	0.000	0.002		
A3	0.20	REF	0.00	B REF		
b	0.18	0.30	0.007	0.012		
D	1.90	2.10	0.075	0.083		
D2	1.00	1.60	0.039	0.063		
E	1.90	2.10	0.075	0.083		
E2	0.60	1.00	0.024	0.039		
е	0.50	BSC	0.02	D BSC		
L	0.30	0.45	0.012	0.018		



Carrier Tape & Reel Dimensions



Application	Α	Н	T1	С	d	D	W	E1	F
	178.0 £ .00	50 MIN.	8.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	8.0 ± 0.20	1.75 ± 0.10	3.50 ± 0.05
TDFN2x2-8	P0	P1	P2	D0	DI	т	A0	DA	K0
I DI INZAL O	FU	F I	F2	00	D1		AU	B0	K0

(mm)

Devices Per Unit

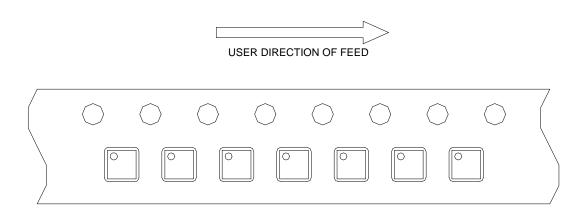
Package Type	Unit	Quantity
TDFN2x2-8	Tape & Reel	3000



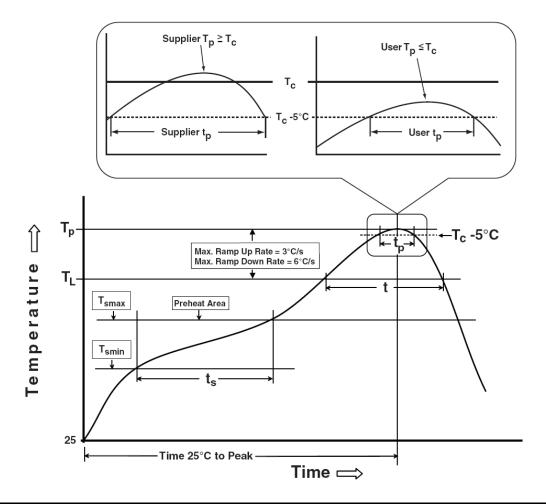


Taping Direction Information

TDFN2x2-8



Classification Profile





Classification Reflow Profiles

-	Pb-Free Assembly
100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
3 °C/second max.	3°C/second max.
183 °C 60-150 seconds	217 °C 60-150 seconds
See Classification Temp in table 1	See Classification Temp in table 2
20** seconds	30** seconds
6 °C/second max.	6 °C/second max.
6 minutes max.	8 minutes max.
-	150 °C 60-120 seconds 3 °C/second max. 183 °C 60-150 seconds See Classification Temp in table 1 20** seconds 6 °C/second max.

** Tolerance for time at peak profile temperature (1_p) is defined as a supplier minimum and a user maximum.

Table 1. SnPb Eutectic Process - Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm ³ ³ 350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HOLT	JESD-22, A108	1000 Hrs, Bias @ 125°C
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
тст	JESD-22, A104	500 Cycles, -65°C~150°C
НВМ	MIL-STD-883-3015.7	VHBM 2KV
MM	JESD-22, A115	VMM 200V
Latch-Up	JESD 78	10ms, 1 _{tr} 100mA



Customer Service

Anpec Electronics Corp.

Head Office : No.6, Dusing 1st Road, SBIP, Hsin-Chu, Taiwan, R.O.C. Tel : 886-3-5642000 Fax : 886-3-5642050

Taipei Branch : 2F, No. 11, Lane 218, Sec 2 Jhongsing Rd., Sindian City, Taipei County 23146, Taiwan Tel : 886-2-2910-3838 Fax : 886-2-2917-3838